Search Notes				

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/695,853	PAPPU ET AL.	
Examiner	Art Unit	
Suchin Parihar	2825	

SEARCHED			
Class	Subclass	Date	Examiner
716	ALL	11/12/2005	SP
324	ALL	11/12/2005	SP
703	14-16	11/16/2005	SP

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
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SEARCH N (INCLUDING SEARC)
	DATE	EXMR
EAST, Text Search US Pat., US PG Pub. Class/Subclass Searched 716/1-18 (see attached) 703/14-16 (see attached)	11/12/2005	SP
IEEE (See attached)	11/16/2005	SP
EAST EPO, JPO, IBMTDB, Derwent (See attached)	11/16/2005	SP
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